

Notice of References Cited	Application/Control No. 10/058,535	Applicant(s)/Patent Under Reexamination HACKENTHAL ET AL.	
	Examiner Brian P Mruk	Art Unit 1751	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,849,105	12-1998	Massaux et al	134/29
	B	US-2002/0137647	09-2002	Hackenthal et al	510/180
	C	US-3,645,904	02-1972	Beach	252/89
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 01/09279	02-2001	Europe	Endlein et al	C11D 17/00
	O	DE 1,669,094	05-1971	Germany	Fauth	C09G 1/02
	P	EP 0,030,986	07-1981	Europe	Mitchell et al	C11D 3/14
	Q	EP 0,216,416	04-1987	Europe	Iding	C11D 3/14
	R	EP 0,335,471	10-1989	Europe	Denis et al	C11D 3/43
	S	WO 97/47724	12-1997	Europe	Erilli et al	C11D 17/00
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.